Se	arch	Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination
10/663,097	LIN ET AL.
Examiner	Art Unit
Trinh Vo Dinh	2821

SEARCHED				
Class	Subclass	Date	Examiner	
343	700ms 702 852 853	3/14/2005	T.D	
	795 797			
	725 776	V	V	
	770 852	3/15/2005	T.D	
	792.5 872			
			-	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East search(subclasses, text, inventors)	3/14/2005	T.D
Search for copending applications using eDAN	3/15/2005	T.D
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